Applicant(s)/Patent Under Application/Control No. Reexamination 09/676,690 SCANLAN, PHILLIP LEE Notice of References Cited Examiner Art Unit Page 1 of 1 2155 Liang-che Alex Wang **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 704/2 US-5,497,319 03-1996 Chong et al. Α Robinson, David W. C. 704/2 06-1994 US-5,323,310 03-2002 Beurket et al. 709/244 US-6,360,273 С US-6,119,078 09-2000 Kobayakawa et al. 704/3 D US-6,205,418 03-2001 Li et al. 704/8 Ε 370/261 07-2003 Roy, Radhika R. US-6,600,725 F US-G US-USı US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Name Classification Country Country Code-Number-Kind Code MM-YYYY JP 11282848 A 10-1999 Japan KATO, YOSHIMORI G06F 17/28 Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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